## Search Notes



1	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10767541	VICK, WAYNE E.
	Examiner	Art Unit
	Choi, Peter Y	1771

SEARCHED						
Class	Subclass	Date	Examiner			
110	77, 97	4/24/2007	PYC			
24	all	4/24/2007	PYC			

SEARCH NOTES				
Search Notes	Date	Examiner		
EAST search	4/24/2007	PYC		
Inventor search	4/24/2007	PYC		

INTERFERENCE SEARCH							
Class	Subclass	Date	Examiner				

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